


<b>Search Notes</b> 	<b>Application/Control No.</b> 10753976	<b>Applicant(s)/Patent Under Reexamination</b> LIEW ET AL.
	<b>Examiner</b> JOHN F RAMIREZ	<b>Art Unit</b> 3737

SEARCHED			
Class	Subclass	Date	Examiner
UPDATED		4/25/2008	JFR
UPDATED		10/28/2009	JFR

SEARCH NOTES		
Search Notes	Date	Examiner
UPDATED	4/25/2008	JFR
UPDATED	10/28/2009	JFR

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/J. F. R./  
Examiner, Art Unit 3737